



RADIO TEST REPORT

Test Report No. : 28FE0090-HO-01-A

Applicant : Sony Computer Entertainment Inc.
Type of Equipment : PLAYSTATION®3
Model No. : CECHJ01
FCC ID : AK8CBEH1300
Test regulation : FCC Part 15 Subpart C 2008
Section 15.207, Section 15.247
Test Result : Complied

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.

Date of test:

January 10 to 24, 2008

Tested by:

T. Shimada

Takumi Shimada
EMC Services

M. Imura

Motoya Imura
EMC Services

Approved by :

M. Fujimura

Mitsuru Fujimura
Assistant Manager of EMC Services



NVLAP LAB CODE: 200572-0

This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation.
*As for the range of Accreditation in NVLAP, you may refer to the WEB address, <http://uljapan.co.jp/emc/nvlap.htm>

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

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CONTENTS	PAGE
SECTION 1: Customer information.....	3
SECTION 2: Equipment under test (E.U.T.).....	3
SECTION 3: Test specification, procedures & results.....	5
SECTION 4: Operation of E.U.T. during testing.....	9
SECTION 5: Conducted Emission.....	12
SECTION 6: Spurious Emission.....	13
SECTION 7: Bandwidth.....	14
SECTION 8: Maximum Peak Output Power.....	14
SECTION 9: Peak Power Density.....	14
APPENDIX 1: Photographs of test setup.....	15
Conducted Emission.....	15
Spurious Emission (Radiated).....	16
Worst Case Position (Horizontal: Y-axis/ Vertical:X-axis).....	17
APPENDIX 2: Data of EMI test.....	20
Conducted Emission.....	20
6dB Bandwidth.....	30
Maximum Peak Output Power.....	33
Radiated Spurious Emission (below 1GHz).....	37
Radiated Spurious Emission (above 1GHz).....	44
Conducted Spurious Emission.....	51
Conducted emission Band Edge compliance.....	58
Power Density.....	59
99% Occupied Bandwidth.....	62
APPENDIX 3: Test instruments.....	64

SECTION 1: Customer information

Company Name	Sony Computer Entertainment Inc.
Brand Name	SONY
Address	2-6-21 Minamiaoyama, Minato-ku, Tokyo, 107-0062, Japan
Telephone Number	+81-3-6438-8023
Facsimile Number	+81-3-6438-8642
Contact Person	Akiko Tsukada

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment	PLAYSTATION®3
Model No	CECHJ01
Serial No	1030165: Used for Conducted emission test 1050034: Used for Conducted emission and antenna terminal conducted tests. 1030177: Used for Radiated spurious emission test.
Rating	AC 120V, 60Hz
Country of Manufacture	JAPAN/CHINA
Receipt Date of Sample	January 9, 2008
Condition of EUT	Engineering prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	No modification by the test lab.

2.2 Product Description

Model: CECHJ01, referred to as the EUT in this report, is a PLAYSTATION®3.
The EUT contains Bluetooth (Ver. 2.0+EDR) module and IEEE802.11b/g WLAN module. Those modules do not transmit simultaneously.

Clock Frequencies are CPU: 3.2GHz(CPU), 66MHz(ATA), 133MHz(ATA), 33MHz(PCI), and 750MHz(SATA1).

List of Model No.:

PLAYSTATION®3

Model No.	Items			Prototype No.
	Destination	Manufacture	Ver.	
CECHJ01	UC2 to North America	SKZ or MTK or FOX	Production, 40 GB, High	CBEH-1401

Debugging Station

Model No.	Items			Prototype No.
	Destination	Manufacture	Ver.	
DECHJ00A	SY5 (World-wide)	SKZ	Debugging Station, 40GB	DEH-H2000A
DECHJ00AS	SY5 (World-wide)	SKZ	Debugging Station (for exhibition), 40GB	DEH-H2000AS
DECHSJ00A	SY5 (World-wide)	SKZ	Debugging Station (for AV Test), 40GB	DEH-S2000A

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

Bluetooth (Ver. 2.0+EDR)

Equipment Type	Transceiver	
Frequency of Operation	2402-2480MHz	
Type of Modulation	FHSS (GFSK, $\pi/4$ -DQPSK, 8DPSK)	
Bandwidth & Channel spacing	1MHz & 1MHz	
Power Supply (inner)	DC3.3V	
Antenna Type	ANT1: Reverse F Antenna (manufacturer: SMK / AMP)	ANT2: Dipole Antenna
Antenna Gain	ANT1: -0.90 dBi (max)	ANT2: -1.20 dBi (max)
Antenna Connector Type	ANT1: N/A	ANT2: N/A

For Bluetooth part, please see UL Japan, Inc. Test Report Number:28FE0090-HO-01-C.

IEEE802.11b/g WLAN

Equipment Type	Transceiver	
Frequency of Operation	2412-2462MHz	
Type of Modulation	DSSS/OFDM	
Bandwidth & Channel spacing	20MHz & 5MHz	
Power Supply (inner)	DC 3.3V/DC1.3V	
Antenna Type	ANT0: Reverse F Antenna	ANT1: Reverse F Antenna
Antenna Gain	ANT0: 3.09 dBi (max)	ANT1: -0.50 dBi (max)
Antenna Connector Type	ANT0: U.FL	ANT1: N/A

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part15 Subpart C: 2008, final revised on January 30, 2008

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.247 Operation within the bands 902-928MHz,
2400-2483.5MHz, and 5725-5850MHz

*The revision on January 30, 2008 does not influence the test specification applied to the EUT.

3.2 Procedures and results

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	Conducted emission	FCC: ANSI C63.4:2003 7. AC powerline conducted emission measurements ----- IC: RSS-Gen 7.2.2	FCC: Section 15.207 ----- IC: RSS-Gen 7.2.2	-	N/A	QP 10.7dB 0.20040, L, Serial: 1030165, 11g, Tx, Ch: Mid, ANTO AV 5.6dB 0.19980, L, Serial: 1030165, 11b, Tx, Ch: Mid, ANTO	Complied
2	6dB Bandwidth	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" ----- IC: RSS-Gen 4.6.2	FCC: Section 15.247(a)(2) ----- IC: RSS-210 A8.2(a)	Conducted	N/A	See data.	Complied
3	Maximum Peak Output Power	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" ----- IC: RSS-Gen 4.8	FCC: Section 15.247(b)(3) ----- IC: RSS-210 A8.4(4)	Conducted	N/A		Complied
4	Restricted Band Edges	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" ----- IC: -	FCC: Section 15.247 (d) ----- IC: RSS-210 A8.5	Conducted/ Radiated	N/A		Complied
5	Power Density	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" ----- IC: -	FCC: Section 15.247 (e) ----- IC: RSS-210 A8.2(b)	Conducted	N/A		Complied
6	Spurious Emission	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" ----- IC: RSS-Gen 4.9 RSS-Gen 4.10	FCC: Section15.247(d) ----- IC: RSS-210 A8.5 RSS-Gen 7.2.1 and 7.2.3	Conducted/ Radiated	N/A	[Tx] 4.1dB 400.004MHz, Hori, 11g, Ch: Low, ANTO 400.008MHz, Hori, 11g, Ch: Mid, ANTO [Rx] 5.9dB 36.130MHz, Vert, Ch: Mid, ANTO	Complied

Note: UL Japan, Inc.'s EMI Work Procedures No.QPM05 and QPM15.

*These tests were performed without any deviations from test procedure except for additions or exclusions.

3.3 Addition to standards

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	99% Occupied Band Width	IC: RSS-Gen 4.6.1	IC: RSS-Gen 4.6.1	Conducted	N/A	N/A	N/A

3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room	Conducted emission	Radiated emission (10m*)				Radiated emission (3m*)			Radiated emission (3m*)	
	150kHz-30MHz	9kHz-30MHz	30MHz-300MHz	300MHz-1GHz	9kHz-30MHz	30MHz-300MHz	300MHz-1GHz	1GHz-18GHz	18GHz-40GHz	
No.1 semi-anechoic Chamber (±)	3.7dB	3.1dB	4.7dB	4.4dB	3.2dB	3.7dB	4.4dB	5.9dB	6.1dB	
No.2 semi-anechoic chamber (±)	3.7dB	-	-	-	3.2dB	4.3dB	3.9dB	5.9dB	6.1dB	
No.3 semi-anechoic chamber (±)	3.7dB	-	-	-	3.2dB	4.2dB	4.4dB	5.9dB	6.1dB	
No.4 semi-anechoic chamber (±)	3.7dB	-	-	-	3.2dB	4.2dB	4.4dB	5.9dB	6.1dB	

*10m/3m = Measurement distance

Conducted emission test

The data listed in this test report has enough margin, more than the site margin.

Radiated emission test(3m)

The data listed in this test report has enough margin, more than the site margin.

Other test except Conducted Emission and Spurious Emission (Radiated)

The measurement uncertainty for this test is 3.0dB.

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

3.5 Test Location

UL Japan, Inc. Head Office EMC Lab. *NVLAP Lab. code: 200572-0
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN
Telephone : +81 596 24 8116 Facsimile : +81 596 24 8124

	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	IC4247	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	IC4247-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	IC4247-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	IC4247-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test set up, Test instruments and Data of EMI

Refer to APPENDIX 1 to 3.

SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

The mode used for test : [IEEE 802.11b / IEEE 802.11g : DSSS / OFDM]

Test	Mode	Tested frequency	Tested antenna
Conducted emission	IEEE802.11b Transmitting (Tx), 11Mbps, PN9 IEEE802.11g Transmitting (Tx), 54Mbps, PN9	2412MHz 2437MHz 2462MHz	ANT0
	----- IEEE802.11b/g Receiving (Rx)	2437MHz	ANT0
6dB Bandwidth Power Density 99% Occupied Bandwidth	IEEE802.11b Transmitting (Tx), 2Mbps, PN9 IEEE802.11g Transmitting (Tx), 12Mbps, PN9	2412MHz 2437MHz 2462MHz	ANT1
	Maximum Peak Output Power	IEEE802.11b Transmitting (Tx), 2Mbps, PN9 IEEE802.11g Transmitting (Tx), 12Mbps, PN9	2412MHz 2437MHz 2462MHz
Spurious Emission (Radiated)	IEEE802.11b Transmitting (Tx), 11Mbps, PN9 IEEE802.11g Transmitting (Tx), 54Mbps, PN9	2412MHz 2437MHz 2462MHz	ANT0
	----- IEEE802.11b/g Receiving (Rx)	2437MHz	ANT0
Spurious Emission (Conducted)	IEEE802.11b Transmitting (Tx), 2Mbps, PN9 IEEE802.11g Transmitting (Tx), 12Mbps, PN9	2412MHz 2437MHz 2462MHz	ANT1
	----- IEEE802.11b/g Receiving (Rx)	2437MHz	ANT1
Restricted Band Edge (Radiated)	IEEE802.11b Transmitting (Tx), 11Mbps, PN9 IEEE802.11g Transmitting (Tx), 54Mbps, PN9	2412MHz 2462MHz	ANT0
	Restricted Band Edge (Conducted)	IEEE802.11b Transmitting (Tx), 2Mbps, PN9 IEEE802.11g Transmitting (Tx), 12Mbps, PN9	2412MHz 2462MHz

*As a result of preliminary check for two antennas (ANT0 and ANT1), the formal test was performed as above-mentioned table.

Preliminary check result (Worst antenna & Data rate):

Conducted Emission & Radiated Emission	11b: ANT0, 11Mbps 11g: ANT0, 54Mbps
Antenna Terminal Conducted test	11b: ANT1, 2Mbps 11g: ANT1, 12Mbps

4.2 Configuration and peripherals

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SECTION 5: Conducted Emission

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 80cm above the conducting ground plane. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center.

For the tests on EUT with other peripherals (as a whole system)

I/O cable and AC cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. All unused 50ohm connectors of the LISN(AMN) were resistivity terminated in 50ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber or a Measurement Room.

The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

Detector : quasi-peak and average detector (IF BW 9 kHz)
Measurement range : 0.15-30MHz
Test data : APPENDIX 2
Test result : Pass

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

SECTION 6: Spurious Emission

[Conducted]

Test Procedure

The Out of Band Emission was measured with a spectrum analyzer connected to the antenna port. It was measured based on "1. RF antenna conducted test" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

The following spectrum analyzer setting was used:

- RBW: 100kHz
- VBW: 300kHz
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

Test data : APPENDIX 2

Test result : Pass

[Radiated]

Test Procedure

It was measured based on "2. Radiated emission test" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 80cm above the conducting ground plane. The Radiated Electric Field Strength intensity has been measured in a Semi Anechoic Chamber with a ground plane and at a distance of 3m(Below 10GHz) and 1m(Upper 10GHz).

The height of the measuring varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

In any 100kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20dBc was applied to the frequency over the limit of FCC 15.209 / Table 2 of RSS-210 2.7 (IC) and outside the restricted band of FCC15.205 / Table 1 of RSS-210 2.7 (IC).

Frequency	Below 1GHz	Above 1GHz
Instrument used	Test Receiver / Spectrum Analyzer	Spectrum Analyzer
Detector	QP: BW 120kHz(T/R)	PK: RBW:1MHz/VBW: 1MHz
IF Bandwidth	20dBc : RBW: 100kHz VBW: 300kHz (S/A)	AV: RBW:1MHz/VBW:10Hz 20dBc : RBW:100kHz/VBW:300kHz

- The carrier level and noise levels were confirmed at each position of X and Y axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Test data : APPENDIX 2

Test result : Pass

UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

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Facsimile : +81 596 24 8124

SECTION 7: Bandwidth

Test Procedure

The bandwidth was measured with a spectrum analyzer connected to the antenna port.
It was measured based on "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".
The following spectrum analyzer setting was used:

- Span: 50MHz
- RBW: 100kHz
- VBW: 300kHz
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

Test data : APPENDIX 2
Test result : Pass

SECTION 8: Maximum Peak Output Power

Test Procedure

The Maximum Peak Output Power was measured with a power meter (tested bandwidth: 50MHz) connected to the antenna port.
It was measured based on "Power Output Option 1" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

Test data : APPENDIX 2
Test result : Pass

SECTION 9: Peak Power Density

[Conducted]

Test Procedure

The Peak Power Density was measured with a spectrum analyzer connected to the antenna port.
It was measured based on "PSD Option 1" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".
The following spectrum analyzer setting was used:

- Span: 1.5MHz
- RBW: 3kHz
- VBW: 100kHz
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

Test data : APPENDIX 2
Test result : Pass

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Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

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